

FORM PTO-1449 (Modified)
U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(Use several sheets if necessary)

(37 CFR 1.98(b))

Any Docket No.: 153494600017

Serial No.: 10/823,257

Applicant(s): Quintero Illera et al.

Filing Date: April 13, 2004

Group: Not Yet Assigned 282.1

U.S. PATENT DOCUMENTS

Exam. Init.		Patent Number							Issue Date	Patentee	Class	Subclass	Filing Date
TP	2002/	0	0	0	0	9	4	0	01/03/2002	Moren et al.			
	2002/	0	0	0	0	9	4	2	01/03/2002	Duroux			
	2002/	0	0	3	6	5	9	4	03/28/2002	Gyones			
	2002/	0	1	0	5	4	6	8	08/08/2002	Tessler et al.			
	2002/	0	1	0	9	6	3	3	08/15/2002	Ow et al.			
	2002/	0	1	2	6	0	5	4	09/12/2002	Fuerst et al.			
	2002/	0	1	2	6	0	5	3	09/12/2002	Lindenmeyer et al.			
	2002/	0	1	7	5	8	6	6	11/28/2002	Gram			
		3	5	2	1	2	8	4	07/21/1970	Shelton, Jr. et al.			
		3	5	9	9	2	1	4	08/10/1971	Altmeier			
		3	6	2	2	8	9	0	11/23/1971	Fujimoto et al.			
		3	6	8	3	3	7	6	08/08/1972	Prenovost			
		3	8	1	8	4	9	0	06/18/1974	Leahy			
		3	9	6	7	2	7	6	06/29/1976	Goubau			
		3	9	6	9	7	3	0	07/13/1976	Fuchser			
		4	0	2	4	5	4	2	05/17/1977	Ikawa et al.			
		4	1	3	1	8	9	3	12/26/1978	Munson et al.			
		4	1	4	1	0	1	6	02/20/1979	Nelson			
		4	4	7	1	3	5	8	09/11/1984	Glasser			
		4	4	7	1	4	9	3	09/11/1984	Schober			
		4	5	0	4	8	3	4	03/12/1983	Garay et al.			
		4	5	4	3	5	8	1	09/24/1985	Nemet			
		4	5	7	1	5	9	5	02/18/1986	Phillips et al.			
		4	5	8	4	7	0	9	04/22/1986	Kneisel et al.			
		4	5	9	0	6	1	4	05/20/1986	Erat			
		4	6	2	3	8	9	4	11/18/1986	Lee et al.			
		4	6	7	3	9	4	8	06/16/1987	Kuo			
		4	7	3	0	1	9	5	03/08/1988	Phillips et al.			
		4	8	3	9	6	6	0	06/13/1989	Hadzoglou			
		4	8	4	3	4	6	8	06/27/1989	Dyewery			
		4	8	4	7	6	2	9	07/11/1989	Shimazaki			
		4	8	4	9	7	6	6	07/18/1989	Inaba et al.			
		4	8	5	7	9	3	9	08/15/1989	Shimazaki			
		4	8	9	0	1	1	4	12/26/1989	Egashira			
		4	8	9	4	6	6	3	01/16/1990	Urbish et al.			
		4	9	0	7	0	1	1	02/06/1990	Kuo			
✓		4	9	1	2	4	8	1	02/27/1990	Mace et al.			✓

TP	4	9	7	5	7	1	12/04/1990	Lee
	5	0	3	0	9	6	07/09/1991	Tudama
	5	1	3	8	3	2	08/11/1992	Zibrik et al.
	5	1	6	8	4	7	12/01/1992	Lockwood
	5	1	7	2	0	8	12/15/1993	Piedzuszko et al.
	5	2	0	0	7	9	04/06/1993	Peller
	5	2	1	4	4	3	05/25/1993	Hsu
	5	2	1	8	3	7	06/08/1993	Blaese
	5	2	2	7	8	0	07/13/1993	Oda
	5	2	2	7	8	0	07/13/1993	Davis
	5	2	4	5	5	5	09/14/1993	Sroka
	5	2	4	8	9	8	09/28/1993	Makino
	5	2	5	5	0	0	10/19/1993	Day
	5	2	5	7	0	3	10/26/1993	Diamond et al.
	5	3	4	7	2	9	09/13/1994	Moore
	5	3	5	5	1	4	10/11/1994	Walton et al.
	5	3	5	5	3	1	10/11/1994	Dionnet et al.
	5	3	7	3	3	0	12/13/1994	Jenness et al.
	5	4	0	2	1	3	03/28/1995	Miller et al.
	5	4	2	0	5	9	05/30/1995	Brkocovic
	5	4	2	2	6	5	06/06/1995	Chang
	5	4	5	1	9	6	09/19/1995	Matsumoto
	5	4	5	1	9	6	09/19/1995	Emery
	5	4	5	3	7	5	09/26/1995	Tsukamoto et al.
	5	4	5	7	4	6	10/10/1995	Diamond et al.
	5	4	7	1	2	2	11/28/1995	Barkeshili
	5	4	9	3	7	0	02/20/1996	Crowley et al.
	5	4	9	5	2	6	02/27/1996	Baker et al.
	5	5	3	4	8	7	07/09/1996	Sorbellio et al.
	5	5	3	7	3	0	07/16/1996	Lockwood et al.
	5	6	8	4	6	7	11/04/1997	Karidis et al.
	5	7	1	2	6	4	01/27/1998	Andou et al.
	5	7	6	7	8	1	06/16/1998	Mandal et al.
	5	7	9	8	6	8	08/25/1998	Schofield
	5	8	2	1	9	0	10/13/1998	Zhu et al.
	5	8	4	1	4	0	11/24/1998	West
	5	8	7	0	0	6	02/09/1999	Asakura et al.
	5	8	7	2	5	4	02/16/1999	Ihara et al.
	5	8	9	8	4	0	04/27/1999	Jou
	5	9	0	3	2	4	05/11/1999	Kawahata et al.
	5	9	2	6	1	4	07/20/1999	Lindenmeier et al.
	5	9	4	3	0	2	08/24/1999	Licendoerfer et al.
	5	9	6	6	0	9	10/12/1999	Qi et al.
	5	9	7	3	6	5	10/26/1999	Suenada et al.
	5	9	8	6	6	1	11/16/1999	Miron
	5	9	9	0	8	3	11/23/1999	Burns et al.
	6	0	0	2	3	6	12/14/1999	Engblom et al.
	6	0	2	8	5	6	02/22/2000	Asakura et al.
	6	0	3	1	4	9	02/29/2000	Dishner
✓	6	0	3	1	5	0	02/29/2000	Qi et al.

TP	6	0	7	8	2	4	06/20/2000	Mitaral											
	6	0	9	1	3	6	07/18/2000	Dumeryd et al.											
	6	0	9	7	3	4	08/01/2000	Walton											
	6	1	0	4	3	4	08/15/2000	Cohen											
	6	1	2	7	9	7	10/03/2000	Cohen											
	6	1	3	1	0	4	10/10/2000	Leo et al.											
	6	1	4	0	9	6	10/31/2000	Lindenmeier et al.											
	6	1	4	0	9	7	10/31/2000	Cohen											
	6	1	6	0	5	1	12/12/2000	Davidson et al.											
	6	1	7	2	6	1	01/09/2001	Hakozaki et al.											
	6	2	1	1	8	2	04/03/2001	Holden et al.											
	6	2	1	8	9	9	04/17/2001	Sadler et al.											
	6	2	3	6	3	7	05/22/2001	Lindenmeier et al.											
	6	2	6	6	0	2	07/24/2001	Nagy et al.											
	6	2	8	1	8	4	08/28/2001	Puente Ballester et al.											
	6	3	0	7	5	1	10/23/2001	Ying et al.											
	6	3	2	9	9	5	12/11/2001	Wen et al.											
	6	3	2	9	9	5	12/11/2001	Fuchs et al.											
	6	3	6	7	9	3	04/09/2002	Carter et al.											
	6	4	0	7	7	1	06/18/2002	Kejlen et al.											
	6	4	1	7	8	1	07/09/2002	Huels et al.											
	6	4	3	1	7	1	08/13/2002	Turnbull											
	6	4	4	5	3	5	09/03/2002	Cohen											
	6	4	5	2	5	4	09/17/2002	Lo											
	6	4	5	2	5	3	09/17/2002	Cohen											
	6	4	7	6	7	6	11/05/2002	Cohen											
	6	5	2	5	6	9	02/25/2003	Varadan et al.											
V	6	5	5	2	6	9	04/22/2003	Veeranarayana											

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

Exam. Init.	Document Number						Publication Date	Country or Patent Office	Class	Subclass	Translation
TP	0	0	9	6	8	4	12/28/1983	EP			X (English Abstract)
	0	2	9	7	8	1	06/24/1988	EP			
	0	3	5	8	0	9	08/29/1989	EP			
	0	5	4	3	6	4	05/26/1993	EP			
	0	5	7	1	1	2	11/24/1993	EP			
	0	6	8	8	0	4	12/20/1995	EP			
	0	7	6	5	0	0	03/26/1997	EP			
	0	8	1	4	5	3	12/29/1997	EP			
	0	8	7	1	2	3	10/145/1898	EP			
	0	8	9	2	4	5	01/20/1999	EP			
	0	8	2	9	1	2	07/14/1899	EP			
	0	9	3	2	2	1	07/28/1999	EP			
	0	9	4	2	4	8	04/18/2000	EP			
	0	9	6	9	3	7	01/05/2000	EP			
	0	9	8	6	1	3	03/15/2000	EP			X (English Abstract)
	0	9	9	7	9	7	05/03/2000	EP			
	1	0	1	8	7	7	07/12/2000	EP			
	1	0	1	8	7	7	07/12/2000	EP			
V	1	0	7	1	1	8	01/24/2001	EP			

TP		1	0	7	9	4	2	02/28/2001	BP				
		1	0	8	3	6	4	03/14/2001	EP				
		1	0	9	4	5	4	04/25/2001	EP				
		1	0	9	6	6	0	05/02/2001	EP				
		1	1	4	8	5	8	10/24/2001	BP				
		1	1	9	8	0	2	04/17/2002	BP				
		1	2	3	7	2	2	09/04/2002	EP			X (English Abstract)	
		1	2	6	7	4	3	12/18/2002	EP				
		2	3	4	3	7	4	10/03/1984	PR			X (English Abstract)	
		2	7	0	4	3	5	10/28/1994	PR				
		3	3	3	7	9	4	05/09/1985	DB			X (English Abstract)	
	5	5	1	4	7	8	0	11/18/1980	JP			X (English Abstract)	
		5	0	0	7	1	0	01/14/1993	JP			X (English Abstract)	
		5	1	2	9	8	1	05/25/1993	JP			X (English Abstract)	
		5	2	6	7	9	1	10/15/1993	JP			X (English Abstract)	
		5	3	4	7	5	0	12/27/1993	JP			X (English Abstract)	
		6	2	0	4	9	0	07/22/1994	JP			X (English Abstract)	
	1	0	2	0	9	7	4	08/07/1988	JP				
		2	1	1	2	1	6	03/16/1998	ES			X (English Abstract)	
		2	1	4	2	2	8	03/06/1998	ES				
		2	2	1	5	1	3	09/13/1989	GB				
		2	3	3	0	9	5	05/05/1999	GB				
		2	3	5	5	1	1	04/11/2001	GB				
		9	5	1	1	5	3	04/27/1995	PCT				
		9	6	2	7	2	1	09/06/1996	PCT				
		9	6	2	9	7	5	09/26/1996	PCT				
		9	6	3	8	8	8	12/03/1996	PCT				
		9	7	0	6	5	7	02/20/1997	PCT				
		9	7	1	1	5	0	03/27/1997	PCT				
		9	7	3	2	3	5	09/04/1997	PCT			X (English Abstract)	
		9	7	3	3	3	3	09/12/1997	PCT				
		9	7	3	5	3	6	09/23/1997	PCT				
		9	7	4	7	0	5	12/11/1997	PCT				
		9	8	1	2	7	7	03/26/1998	PCT				
		9	8	3	6	4	6	08/20/1998	PCT				
		9	9	0	3	1	6	01/21/1999	PCT				
		9	9	0	3	1	6	01/21/1999	PCT				
		9	9	2	5	0	4	03/20/1999	PCT				
		9	9	2	7	6	0	06/03/1999	PCT				
		9	9	5	6	3	4	11/04/1999	PCT				
		0	0	0	1	0	2	01/06/2000	PCT				
		0	0	0	3	4	5	01/20/2000	PCT				
		0	0	2	2	6	9	04/20/2000	PCT				
		0	0	3	6	7	0	06/22/2000	PCT				
		0	0	4	9	6	8	08/24/2000	PCT				
		0	0	5	2	7	8	09/08/2000	PCT				

TP	0	0	3	2	7	7	09/08/2000	PCT
	0	1	0	3	2	8	01/11/2001	PCT
	0	1	0	8	2	5	02/01/2001	PCT
	0	1	1	3	4	6	02/22/2001	PCT
	0	1	1	7	0	6	03/08/2001	PCT
	0	1	2	2	5	2	03/29/2001	PCT
	0	1	2	4	3	1	04/05/2001	PCT
	0	1	2	6	1	8	04/12/2001	PCT
	0	1	2	8	0	3	04/19/2001	PCT
	0	1	3	1	7	3	05/03/2001	PCT
	0	1	3	3	6	6	05/10/2001	PCT
	0	1	3	8	4	9	05/17/2001	PCT
	0	1	3	7	3	6	05/23/2001	PCT
	0	1	3	7	3	7	05/25/2001	PCT
	0	1	4	1	2	5	06/07/2001	PCT
	0	1	4	8	8	6	07/05/2001	PCT
	0	1	5	4	2	2	07/26/2001	PCT
	0	1	7	3	8	9	10/04/2001	PCT
	0	1	7	8	1	9	10/18/2001	PCT
	0	1	8	2	4	1	11/01/2001	PCT
	0	2	3	5	6	4	05/02/2002	PCT
	0	2	0	9	1	3	11/14/2002	PCT
✓	0	2	0	9	6	1	11/28/2002	PCT

OTHER DOCUMENTS (Including Author, Title, Date**, Relevant pages, Place of Publication***)

TP	All, M. et al., "A Triple-Band Internal Antenna for Mobile Hand-held Terminals," IEEE, pp. 32-35 (1992)
	Romeu, Jordi et al., "A Three Dimensional Hilbert Antenna," IEEE, pp. 550-553 (2002)
	Parker et al., "Microwaves, Antennas & Propagation," IEEE Proceedings H, pp. 14-22 (February 1991)
	Hansen, R.C., "Fundamental Limitations in Antennas," Proceedings of the IEEE, Vol. 69, No. 2, pp. 170-182 (February 1981)
	Jaggard, Dwight L., "Fractal Electrodynamics and Modeling," Directions in Electromagnetic Wave Modeling, pp. 435-446 (1991)
	Hohlfeld, Robert G. et al., "Self-Similarity and the Geometric Requirements for Frequency Independence in Antennas," Fractals, Vol. 7, No. 1, pp. 79-84 (1999)
	Samavati, Hiras, et al., "Fractal Capacitors," IEEE Journal of Solid-State Circuits, Vol. 33, No. 12, pp. 2035-2041 (December 1998)
	Pribetich, P., et al., "Quasifractal Planar Microstrip Resonators for Microwave Circuits," Microwave and Optical Technology Letters, Vol. 21, No. 6, pp. 433-436 (June 20, 1999)
	Zhang, Dawei, et al., "Narrowband Lumped-Element Microstrip Filters Using Capacitively-Loaded Inductors," IEEE MTT-S Microwave Symposium Digest, pp. 379-382 (May 16, 1995)
	Gough, C.E., et al., "High Tc coplanar resonators for microwave applications and scientific studies," Physics C, NL, North-Holland Publishing, Amsterdam, Vol. 282-287, No. 2001, pp. 395-398 (August 1, 1997)
	Radio Engineering Reference-Book by H. Meinke and F.V. Gundlach, Vol. 1, Radio components. Circuits with lumped parameters. Transmission lines. Wave-guides. Resonators. Arrays. Radio waves propagation, States Energy Publishing House, Moscow, with English translation (1961) (4 pp.)
	V.A. Volgov, "Parts and Units of Radio Electronic Equipment (Design & Computation)," Energiya, Moscow, with English translation (1967) (4 pp.)
	Puente, C., et al., "Multiband properties of a fractal tree antenna generated by electrochemical deposition," Electronics Letters, IEE Stevenage, GB, Vol. 32, No. 25, pp. 2298-2299 (December 5, 1996)
	Puente, C., et al., "Small but long Koch fractal monopole," Electronics Letters, IEE Stevenage, GB, Vol. 34, No. 1, pp. 9-10 (January 8, 1998)
	Puente Balinda, Carlos, et al., "The Koch Monopole: A Small Fractal Antenna," IEEE Transactions on Antennas and Propagation, New York, US, Vol. 48, No. 11, pp. 1773-1781 (November 1, 2000)
	Cohen, Nathan, "Fractal Antenna Applications in Wireless Telecommunications," Electronics Industries Forum of New England, 1997. Professional Program Proceedings Boston, MA US, May 6-8, 1997, New York, NY, US, IEEE, US pp. 43-49 (May 6, 1997)
	Anguera, J. et al., "Miniature Wideband Stacked Microstrip Patch Antenna Based on the Sierpinski Fractal Geometry," IEEE Antennas and Propagation Society International Symposium, 2000 Digest. App., vol. 3 of 4, pages 1700-1703 (July 16, 2000)
✓	Hara Prasad, R.V., et al., "Microstrip Fractal Patch Antenna for Multi-Band Communication," Electronics Letters, IEE Stevenage, GB, vol. 36, no. 14, pages 1179-1180 (July 6, 2000)

TP	Borja, C. et al., "High Directive Fractal Boundary Microstrip Patch Antenna," Electronics Letters, IEE Stevenage, GB, vol. 36, no. 9, pages 778-779 (April 27, 2000)
↓	Sanad, Mohamed, "A Compact Dual-Broadband Microstrip Antenna Having Both Stacked and Planar Parasitic Elements," IEEE Antennas and Propagation Society International Symposium 1998 Digest, July 21-26, 1998, pp. 6-9
Examiner	THO PHAN
	Date Considered 6/30/06
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



Substitute for form 1449/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	10/823257-Conf. #3496
		Filing Date	April 13, 2004
		First Named Inventor	Ramiro Quintero Illera
		Art Unit	2821
		Examiner Name	T. G. Phan
Sheet 1 of 1	Attorney Docket Number	68349-00011USPX	

U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number-Kind Code ² (if known)		
TP ↓	A1*	US-6,545,640	04-08-2003	Herve et al.
	A2*	US-6,606,062-A1	08-12-2003	Ngounou Kouam et al.
	A3*	US-6,664,932-A1	12-16-2003	Sabet et al.
	A4*	US-20020003499-A1	12-17-2002	Kouam et al.

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T ³
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
TP	B1	EP-1128466	08-29-2001	Filtronic LK Oy	
↓	B2	WO-02/095874	11-28-2002	Raytheon Company	

*EXAMINER: Initial if information considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		T ²
TP	C1	"Small Cicularatory Polarized Microstrip Antennas" by Wen-Shyang Chen, Department of Electronic Engineering, Cheng-Shiu Institute of Technology, 1999 IEEE.		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ³ Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	6/30/06
-----------------------	--	--------------------	---------

This Page is inserted by IFW Indexing and Scanning Operations and is not part of the Official Record

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- ☐ BLACK BORDERS
- ☐ IMAGE CUT OFF AT TOP, BOTTOM OR SIDES
- ☐ FADED TEXT OR DRAWING
- ☒ BLURED OR ILLEGIBLE TEXT OR DRAWING
- ☐ SKEWED/SLANTED IMAGES
- ☐ COLORED OR BLACK AND WHITE PHOTOGRAPHS
- ☐ GRAY SCALE DOCUMENTS
- ☐ LINES OR MARKS ON ORIGINAL DOCUMENT
- ☐ REPERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY
- ☐ OTHER: _____

IMAGES ARE BEST AVAILABLE COPY.

As rescanning documents *will not* correct images problems checked, please do not report the problems to the IFW Image Problem Mailbox